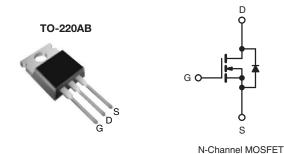


## **Power MOSFET**

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	600				
$R_{DS(on)}(\Omega)$	V <sub>GS</sub> = 10 V	2.2			
Q <sub>g</sub> (Max.) (nC)	23				
Q <sub>gs</sub> (nC)	5.4				
Q <sub>gd</sub> (nC)	11				
Configuration	Single				



## **FEATURES**

• Low Gate Charge Qq Results in Simple Drive Requirement



 Improved Gate, Avalanche and Dynamic dV/dt RoHS Ruggedness

- Fully Characterized Capacitance and Avalanche Voltage and Current
- Effective Coss Specified
- Compliant to RoHS Directive 2002/95/EC

## **APPLICATIONS**

- Switch Mode Power Supply (SMPS)
- Uninterruptable Power Supply
- High Speed Power Switching

## **TYPICAL SMPS TOPOLOGY**

• Single Transistor Flyback

ORDERING INFORMATION	
Package	TO-220AB
Lead (Pb)-free	IRFBC30APbF
Lead (FD)-life	SiHFBC30A-E3
SnPb	IRFBC30A
SIIFU	SiHFBC30A

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	600	V	
Gate-Source Voltage			$V_{GS}$	± 30	V	
Continuous Proin Current	V -140V	$T_{\rm C} = 25  ^{\circ}{\rm C}$ $T_{\rm C} = 100  ^{\circ}{\rm C}$		3.6		
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C	I <sub>D</sub>	2.3	А	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	14		
Linear Derating Factor				0.69	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	290	mJ	
Repetitive Avalanche Currenta			I <sub>AR</sub>	3.6	Α	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	7.4	mJ	
Maximum Power Dissipation $T_C = 25  ^{\circ}C$			$P_{D}$	74	W	
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	7.0	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for	10 s		300 <sup>d</sup>	7	
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N · m	

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Starting  $T_J$  = 25 °C, L = 41 mH,  $R_q$  = 25  $\Omega$ ,  $I_{AS}$  = 3.6 A (see fig. 12).
- c.  $I_{SD} \le 3.6$  A,  $dI/dt \le 170$  A/µs,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150$  °C.
- d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply

# IRFBC30A, SiHFBC30A



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	62			
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.50	-	°C/W		
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	1.7			

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		600	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I <sub>D</sub> = 1 mA	-	0.67	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	$V_{DS} = V_{GS}, I_D = 250 \mu A$		-	4.5	V
Gate-Source Leakage	I <sub>GSS</sub>	\	V <sub>GS</sub> = ± 30 V		-	± 100	nA
Zero Gate Voltage Drain Current	lnoo	V <sub>DS</sub> = 600 V, V <sub>GS</sub> = 0 V		-	-	25	uА
Zero date voltage Brain Gunent	I <sub>DSS</sub>	$V_{DS} = 480 \text{ V}$	V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	250	μΑ
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	$I_D = 2.2 A^b$	-	-	2.2	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> =	$50 \text{ V}, I_D = 2.2 \text{ A}^b$	2.1	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>		$V_{GS} = 0 V$ ,	-	510	-	_
Output Capacitance	C <sub>oss</sub>		$V_{DS} = 25 \text{ V},$	-	70	-	
Reverse Transfer Capacitance	$C_{rss}$	T = 1.0	f = 1.0 MHz, see fig. 5		3.5	-	_ הר
Output Capacitance	C <sub>oss</sub>		$V_{DS} = 1.0 \text{ V}, f = 1.0 \text{ MHz}$	-	730	-	pF
		$V_{GS} = 0 V$	$V_{DS} = 480 \text{ V}, f = 1.0 \text{ MHz}$	-	19	-	
Effective Output Capacitance	C <sub>oss</sub> eff.		V <sub>DS</sub> = 0 V to 480 V <sup>c</sup>		31	-	
Total Gate Charge	$Q_g$			-	-	23	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	$I_D = 3.6 \text{ A}, V_{DS} = 480 \text{ V}$ see fig. 6 and 13 <sup>b</sup>	-	-	5.4	nC
Gate-Drain Charge	Q <sub>gd</sub>		3 7 7 7	-	-	11	
Turn-On Delay Time	t <sub>d(on)</sub>				9.8	-	
Rise Time	t <sub>r</sub>	V <sub>DD</sub> =	300 V, I <sub>D</sub> = 3.6 A,	-	13	-	ns
Turn-Off Delay Time	t <sub>d(off)</sub>		$R_D = 82 \Omega$ , see fig. $10^b$	-	19	-	
Fall Time	t <sub>f</sub>			-	12	-	
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the integral reverse p - n junction diode		-	-	3.6	
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	14	A
Body Diode Voltage	$V_{SD}$	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 3.6 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	1.6	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 3.6 A, dl/dt = 100 A/μs <sup>b</sup>		-	400	600	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	1.1	1.7	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_I$				1 - \	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.
- c.  $C_{oss}$  eff. is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DS}$ .



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

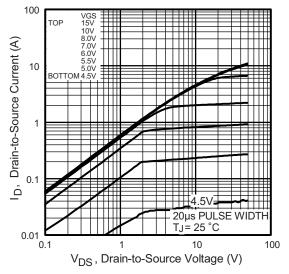


Fig. 1 - Typical Output Characteristics

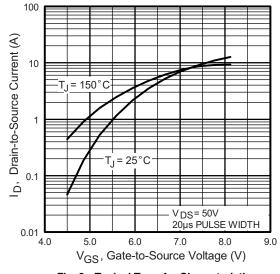


Fig. 3 - Typical Transfer Characteristics

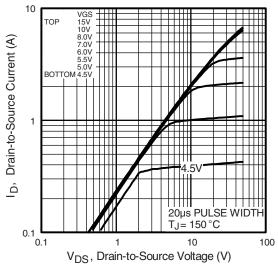


Fig. 2 - Typical Output Characteristics

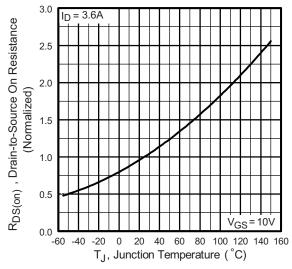


Fig. 4 - Normalized On-Resistance vs. Temperature



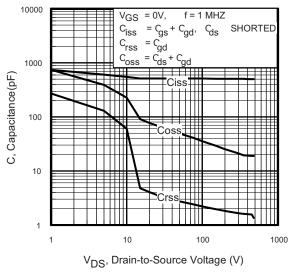


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

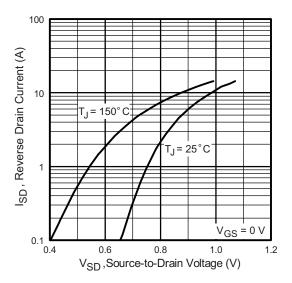


Fig. 7 - Typical Source-Drain Diode Forward Voltage

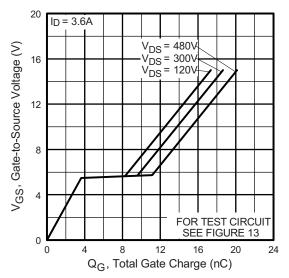


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

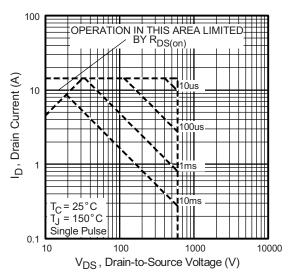


Fig. 8 - Maximum Safe Operating Area

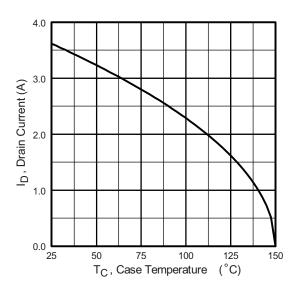


Fig. 9 - Maximum Drain Current vs. Case Temperature

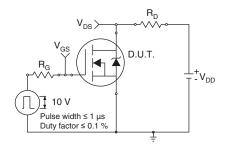


Fig. 10a - Switching Time Test Circuit

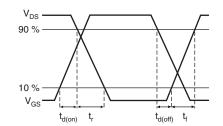


Fig. 10b - Switching Time Waveforms

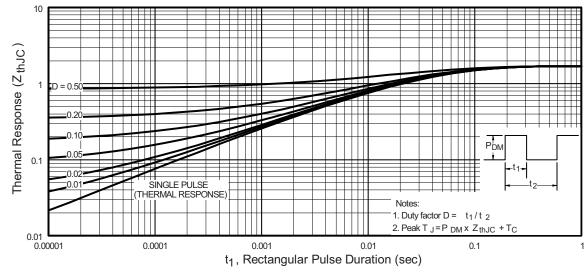


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

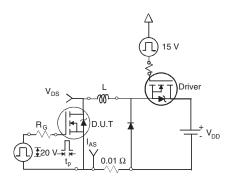


Fig. 12a - Unclamped Inductive Test Circuit

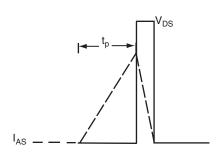


Fig. 12b - Unclamped Inductive Waveforms



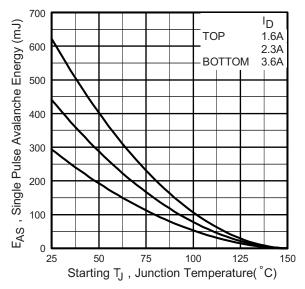


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

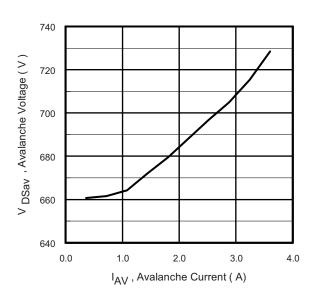


Fig. 12d - Typical Drain-to-Source Voltage vs.
Avalanche Current

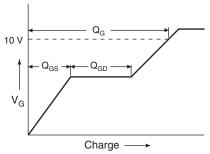


Fig. 13a - Basic Gate Charge Waveform

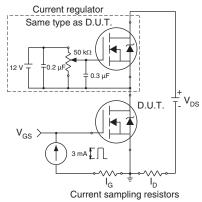
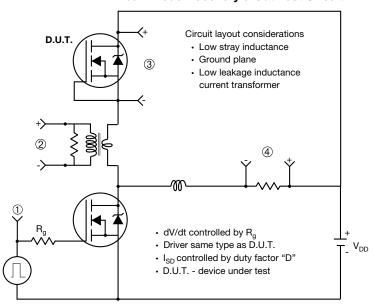


Fig. 13b - Gate Charge Test Circuit

## Peak Diode Recovery dV/dt Test Circuit



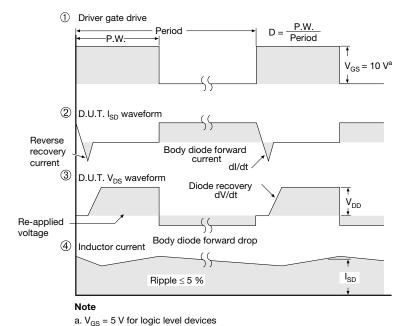
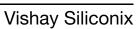


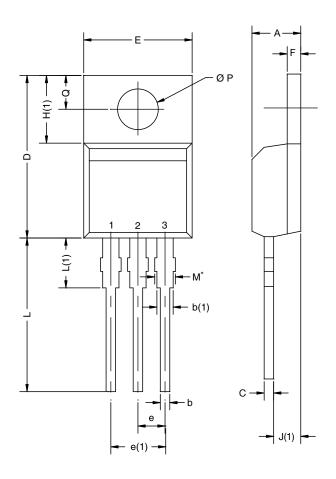
Fig. 14 - For N-Channel

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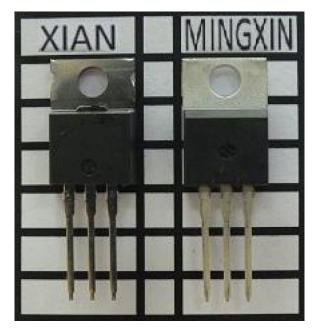
# **TO-220AB**



	MILLIM	IETERS	INCHES			
DIM.	MIN.	MAX.	MIN.	MAX.		
Α	4.25	4.65	0.167	0.183		
b	0.69	1.01	0.027	0.040		
b(1)	1.20	1.73	0.047	0.068		
С	0.36	0.61	0.014	0.024		
D	14.85	15.49	0.585	0.610		
E	10.04	10.51	0.395	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.09	6.48	0.240	0.255		
J(1)	2.41	2.92	0.095	0.115		
L	13.35	14.02	0.526	0.552		
L(1)	3.32	3.82	0.131	0.150		
ØР	3.54	3.94	0.139	0.155		
Q	2.60	3.00	0.102	0.118		
ECN: X12-0208-Rev. N, 08-Oct-12 DWG: 5471						

#### **Notes**

- $^{\star}$  M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM
- Xi'an and Mingxin actual photo





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Revision: 02-Oct-12 Document Number: 91000